



Paradox of peroxy defects and positive holes in rocks Part II: Outflow of electric currents from stressed rocks



John Scoville^{a,b,c}, Jaufray Sornette^c, Friedemann T. Freund^{a,b,d,e,*}

^aGeoCosmo Science and Research Center, Moffett Field, CA 94035, United States

^bSan Jose State University, Dept of Physics, San Jose, CA 95192-0106, United States

^cNASA Ames Research Center, Moffett Field, CA 94035, United States

^dSETI Institute, Mountain View, CA 94043, United States

^eNASA Ames Research Center, Earth Science Division, MS 245-4, Moffett Field, CA 94035, United States

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ABSTRACT

Understanding the electrical properties of rocks is of fundamental interest. We report on currents generated when stresses are applied. Loading the center of gabbro tiles, $30 \times 30 \times 0.9 \text{ cm}^3$, across a 5 cm diameter piston, leads to positive currents flowing from the center to the unstressed edges. Changing the constant rate of loading over 5 orders of magnitude from 0.2 kPa/s to 20 MPa/s produces positive currents, which start to flow already at low stress levels, <5 MPa. The currents increase as long as stresses increase. At constant load they flow for hours, days, even weeks and months, slowly decreasing with time. When stresses are removed, they rapidly disappear but can be made to reappear upon reloading. These currents are consistent with the stress-activation of peroxy defects, such as $\text{O}_2\text{Si}-\text{OO}-\text{SiO}_3$, in the matrix of rock-forming minerals. The peroxy break-up leads to positive holes h^\cdot , i.e. electronic states associated with O^- in a matrix of O^{2-} , plus electrons, e' . Propagating along the upper edge of the valence band, the h^\cdot are able to flow from stressed to unstressed rock, traveling fast and far by way of a phonon-assisted electron hopping mechanism using energy levels at the upper edge of the valence band. Impacting the tile center leads to h^\cdot pulses, 4–6 ms long, flowing outward at $\sim 100 \text{ m/s}$ at a current equivalent to $1-2 \times 10^9 \text{ A/km}^3$. Electrons, trapped in the broken peroxy bonds, are also mobile, but only within the stressed volume.

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1. Introduction

The electrical properties of rocks are of fundamental interest for many aspects of the physics of the solid Earth (Fuji-ta et al., 2004; Nover, 2005). This includes processes that can be linked to earthquake and pre-earthquake conditions. Surprisingly, wide gaps remain in the knowledge base, in particular with respect to understanding how electric currents are generated in the rocks at those depths, about 35–45 km, where the majority of destructive earthquakes occur and where the temperatures along the geotherm typically increase to about 600 °C.

In Part I of this two-part paper we dealt with changes in electrical conductivity upon heating to about 600 °C. In this Part II we deal with stress and how the application of uniaxial stresses affects the electrical properties of rocks. The goal is to contribute to our

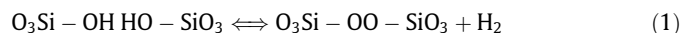
understanding of the processes that take place when tectonic stresses in the Earth's crust wax and wane, changing the electrical properties of rocks and how this may lead to identifiable signals, which the Earth sends out prior to major earthquakes.

At the outset we note that in the seismogenic zone, between 5–7 km to 35–45 km depth, where some 85% of destructive earthquakes occur, the rocks are essentially all igneous or high-grade metamorphic, meaning that they have either crystallized from magmas or experienced elevated temperatures as part of their geological history. Hence, at high temperatures, when thermodynamic equilibrium conditions prevail, minerals in these rocks dissolve, i.e. incorporate in their crystal structures, small amounts of gas/fluid components forming solid solutions, ss. The gas/fluid component of prime interest is H_2O , which enters the host mineral structures in the form of hydroxyl, $\text{O}_2\text{Si}-\text{OH}$. During cooling the solid solutions inevitably drift out of thermodynamic equilibrium and become supersaturated solid solutions, sss. It is in this non-equilibrium state that a long overlooked redox conversion occurs, in the course of which the two hydroxyl oxygens transfer

* Corresponding author at: NASA Ames Research Center, MS 245-4, Moffett Field, CA 94035, United States.

E-mail address: friedemann.t.freund@nasa.gov (F.T. Freund).

each on electron onto the hydroxyl proton, thereby turning two H^+ into H_2 and oxidizing the two oxygens to the 1 – valence state. The two O^- combine to form a peroxy bond:



Part I was dedicated to the break-up of the peroxy bond upon heating. Part II will look at the same break-up reaction using stress as the cause.

Under Earth's surface conditions, crustal rocks are fairly good electrical insulators. A common way to address electrical properties of rocks in laboratory experiments is to measure their electrical conductivity. This is generally done by placing a rock sample, often a disk or a cylinder with flat faces as depicted in Fig. 1a, between two electrodes. A voltage is then applied to produce an alternating current (ac) in the range of kHz to MHz or a direct current (dc). An ac voltage causes charges or dipoles to oscillate forth and back within the sample. A dc voltage will drive mobile charge carriers through the sample. A guard electrode may be added to catch currents flowing along the sample surface, allowing to separately monitor the currents flowing along the surface and through the bulk. Stresses may be applied, either uniaxially or triaxially (Heikamp and Nover, 2001).

The term “stress” is often used in somewhat imprecise ways. The dimension of stress is that of pressure in units of Pascals (Pa), given as Newtons per m^2 . Solids can support both normal (compressional) and shear stresses where normal stresses are perpendicular to the surface and shear stresses parallel to it. Loading a cylinder uniaxially creates mostly normal stresses but there is always also a shear stress component. In the context of this Part II the shear stress components are most important.

Applying mechanical stresses to igneous or high-grade metamorphic rocks has long been recognized to lead to an increase in electrical conductivity, particularly during shock-loading (Gorshkov et al., 2001). Several explanations for the increased conductivity have been offered in the literature such as improved grain–grain contacts (Glover, 1996; Nover, 2005) or thin graphite layers forming spontaneously on internal crack surfaces (Nover et al., 2005).

Fig. 1b illustrates an experimental set-up of the type described in the literature to measure pressure-stimulated voltages or currents, which the voltages generate (Aydin et al., 2009; Johnston, 1997; Kyriazis et al., 2009; Triantis et al., 2006; Tullis, 2002; Vallianatos and Triantis, 2008, 2012). Generally the rock cylinders or disks are loaded over their entire cross sections (Brace, 1965, 1968). Due to unavoidable inhomogeneities in the set-up or in the local materials properties, this will lead to nonuniform distributions of normal and shear stresses across of the rock samples. They manifest themselves in erratic potential differences between different parts of the stressed rock cylinders, making it difficult, if not impossible, to use those potential differences to derive information about the sign and the flow of charge carriers.

On a dynamically active planet like Earth, stress gradients are the most characteristic collateral of pre-earthquake conditions. Stress gradients act over a wide range of distances. They wax and wane on many time scales (Zoback et al., 1987; Sornette et al., 1994; Seeber and Armbruster, 2000; Anderson and Ji, 2003; Kagan et al., 2005). If we suspect that stresses can cause electric currents, it is advisable to stay away from applying external voltages to the rock sample. Instead we should set up laboratory experiments in such a way that stress gradients become an integral part of the design and that stress-generated currents (and voltages) can be measured. After all, while Nature is known to produce ample stress gradients across rocks in the Earth's crust, Nature does not apply specific voltages, in particular not ac voltages in the kHz to MHz range such as often used in conventional electrical conductivity measurements.

Hence, instead of applying an external electric field to drive existing charge carriers through the rock sample as depicted in Fig. 1a or using a quasi-uniformly loaded cylindrical sample to cause stress-stimulated charges to build up hard-to-interpret voltages as depicted in Fig. 1b, we subject one end of a rock sample to uniaxial load as shown in Fig. 1c and d, leaving the other, unloaded end stress-free. Placing a voltmeter or an ammeter into the electric circuit we capture self-generated voltages and currents, activated by stress, between the stressed and unstressed ends of the rock. Experiments as sketched in Fig. 1c and d closely imitate real

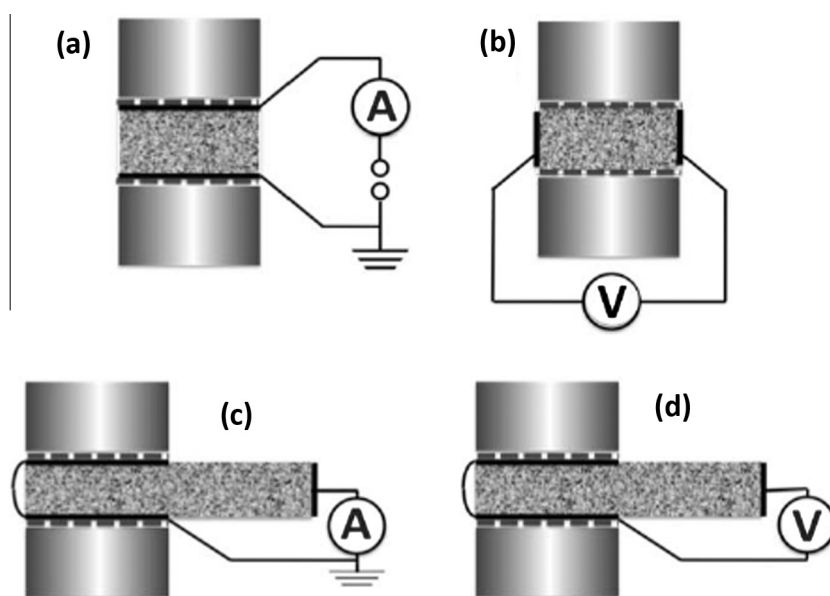


Fig. 1. (a) Exemplary set-up for an electrical conductivity measurement of a rock sample subjected to uniaxial load, where the current measured by the ammeter is driven through the sample by an externally applied dc or ac field. (b) Exemplary set-up for measuring a pressure-stimulated voltage in a quasi-uniformly loaded cylindrical rock sample. (c and d) Set-up for measuring currents and electrical potentials along a stress gradient without externally applied electric potentials. Dashed lines: insulator sheets solid lines: metal contacts.

situations in the field, because stress gradients are part of any system in the Earth's crust and stress gradients are of interest when focusing on pre-earthquake processes. We thus use stress gradients as the thermodynamic driving force causing mobile charge carriers to flow.

An experimental set-up as shown in Fig. 1c and d was used earlier to provide information about charge carriers that become stress-activated, and flow out of the stressed subvolume, leading to the concept that rocks, when stressed, behave like a battery (Freund et al., 2006; Takeuchi et al., 2006). Here we focus on the rate at which stresses are applied and the magnitude of the currents.

Prior to the formulation of the battery concept, impact experiments had been conducted where cylinders of various igneous rocks or blocks of granite were hit with projectiles over the velocity range from about 100 m s^{-1} to 1.5 km s^{-1} with some experiments up to 4.5 and 5.6 km s^{-1} (Freund, 2002). The low velocity impacts suggested that positive charges were created by the burst of stress delivered to the point of impact, able to spread without externally applied voltage along the cylinder axis (Freund, 2002). In the case of higher velocity impacts the seismic waves propagating from the impact point led to an instantaneous activation of positive charges throughout the rock volume. Due to Coulomb repulsion these charge carriers began to redistribute inside the rock, spreading to the rock surface at their characteristic speed, leading to a positive surface charge, which in turn led to surface/subsurface electric fields and to follow-on reactions.

Geological stress gradients develop where tectonic plates are shifting relative to each other. The gradients usually evolve slowly with time. In pre-earthquake situations stress gradients will evolve increasingly fast as the time of catastrophic failure approaches. In fact, in any rock volume deep in the Earth's crust, which is destined to become the hypocenter of an earthquake, failure under the overload of 10–30 km of rocks will differ significantly from the breaking of rocks in laboratory experiments where rock cylinders, usually unconfined, are loaded. Because of the lack of confinement, the rock cylinders can bulge outward, reduce the overall stress by increasing the volume, and initiate failure at the surface by tensile stress.

By contrast, rock volumes deep in the Earth's crust can hardly increase in volume. The build-up of *in situ* stresses is primarily controlled by the repulsive interactions between atoms and ions that are pushed closer together by the external forces. These repulsive interactions scale with the inverse of r^9 to r^{12} , where r are the interatomic distances. This very steep increase causes the *in situ* stresses to evolve over increasingly shorter timescales until failure occurs by shear (Freund and Sornette, 2007). For this reason, in this Part II, we report on rock stressing experiments for which the rate of loading was increased from slow to very fast, spanning 8 orders of magnitude.

2. Experimental method

2.1. Samples

Gabbros are the depth equivalent of basalts, the most common effusive igneous rock formed from magmas that rise from upper mantle depths (Green and Ringwood, 1967). We conducted our experiments with rock tiles, $30 \times 30 \times 0.9 \text{ cm}^3$, stressed in the center. The tiles consisted of fine-grained, black gabbro from Shanxi, China, commercially available under the trade name "Absolute Black". One side was polished, the other side and the edges were saw-cut rough. The modal composition of this gabbro¹ is approximately 40% plagioclase (about 80% albite and 20% anorthite), 30%

clinopyroxene (augite) with minor alteration to amphibole and/or chlorite, and 25% opaques, probably magnetite, plus rims of a reddish mineral, possibly iddingsite. Because they are commercially available, we were able to obtain a large batch of visually homogeneous tiles from the same location.

Identical experiments were conducted with regular plate glass, Ca–Na–aluminosilicate, of the same thickness, 0.9 cm, cut to the same dimensions, $30 \text{ cm} \times 30 \text{ cm}$, and fitted with a pair of 5 cm diameter Cu electrodes in the center and the same Cu electrode continuously along the edges.

2.2. Hydraulic press experiments

We conducted tests at slow to moderately fast, constant loading rates in an IPC Universal Testing Machine, UTM 100, capable of delivering 100 kN load, controlled at the $\pm 1 \text{ N}$ level. To reduce the electric noise we converted the UTM 100 environmental chamber into a Faraday cage by covering the glass window door with grounded aluminum (Al) foil. All leads to the rock samples were either BNC cables or Cu leads shielded with grounded Al foil.

The tiles were centrally loaded between two steel pistons, 3.9 or 5.0 cm diameter (Fig. 2a/b). The pistons were electrically insulated from the press by 0.5 mm thick polyethylene sheets. Copper contacts with graphite-based adhesive (3 M Corporation), were applied to the rock surface underneath both pistons. Cu stripes, 0.67 cm wide, were applied along the edges of the tiles. The out-flow currents were measured between the central stressed volume and the edges of the tiles. For recording potential differences between the stressed rock volume and the surface of the tiles we used a large-area capacitive sensor consisting of Cu tape applied to the backside of a 0.5 mm thick sheet of polyethylene lying loosely on the polished side of the tile.

For current measurements, the HI (high) side of a Keithley 617 electrometer was connected to the edge Cu electrode, while the LO (low) side was connected to the center contact and to ground (Fig. 2b). For voltage measurements, the same Keithley 617 was used in voltage mode. For data acquisition we used LabVIEW (National Instruments Corp.). As a rule we allowed the rock tiles to anneal without load at room temperature for several hours or overnight before loading or reloading.

We loaded the tiles from 0 MPa to pre-set maximum stress levels, using fast loading at a pre-set level or slow loading at constant rates, varying over 5 orders of magnitude, from 0.2 kPa/s to over 60 MPa/s. Typical maximum stress levels ranged from 48 to 63 MPa, corresponding to less than 1/3 the load necessary to cause unconfined gabbro or the plate glass to fail.

2.3. Free-fall acceleration experiments

A Monterey Research Laboratory, Inc. Model Impac 66 drop tower was used to load the gabbro tiles more rapidly, within

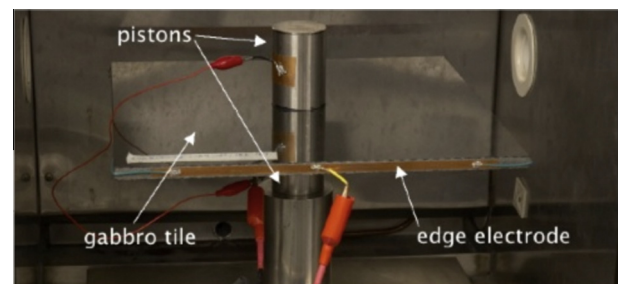


Fig. 2. Photograph of a gabbro tile inside the Faraday cage set up to be loaded through two pistons in the center.

¹ Courtesy of the late Paul Lohman, Geodynamics Laboratory, NASA Goddard Space Flight Center.

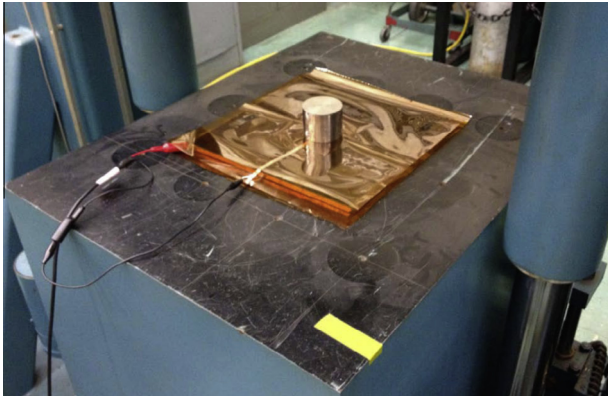


Fig. 3. Experiment configuration for a drop-tower experiment with impact to take place on a 5 cm diameter stainless steel piston on the center of the rock tile to measure the flow of charge carriers from the stressed rock volume underneath the piston through unstressed rock to the edge. Kapton sheets are used as insulators.

0.5–2 ms by dropping a 90.7 kg aluminum weight from various heights onto a 2-ton spring-mounted steel body. We dropped the weight onto a 5 cm diameter steel piston placed on a 5 cm diameter Cu electrode at the tile center as shown in Fig. 2b, cushioning the impact with two to three felt pads. The rebound of the drop mass was halted by air brakes. The drop height was varied from 5 cm to about 25 cm, resulting in accelerations from 250 g to 1100 g (2450–10,780 m/s²) over 0.5–2 ms, corresponding to a forces on the order of 220–980 kN, as measured with an accelerometer installed on the drop mass. The force during impact was distributed over an area of ~20 cm² leading to peak pressures ranging from 100 to 500 MPa.

Fig. 3 shows a tile being readied to a drop experiment. The Cu contact along the edges can be seen. Beneath the 5 cm diameter piston is a 5 cm diameter Cu contact on the topside of the tile and an identical Cu contact on the underside. Kapton sheets, 50 μm thick, were used to electrically insulate the tile from its support and from the drop mass. Kapton also served to insulate thin Cu stripes between two Kapton sheets to contact the 5 cm diameter electrodes at the center of the tile, on the top and the bottom face.

Kinetically, the drop experiments differed from the runs with the hydraulic press in as much as the rate of stress increase during the impacts was essentially parabolic. After each drop test the tiles were inspected for cracks, and the accelerometer output was inspected for signs of cracking as evidenced by jagged leading edges on what would otherwise show as smooth, approximately parabolic acceleration curves. High impact pressures in combination with minimal padding often caused the tiles to crack, resulting in mechanical and radiative energy dissipation in addition to noisy data. If a tile was found to have fractured, its data were excluded from further analysis. By reducing the drop height we obtained usable data with and without padding. After identifying the right conditions under which most tiles survived the impacts, we subjected those tiles to several consecutive impacts, separated by only a few minutes between drops.

The currents during impacts were recorded by connecting the red terminal of a Stanford Research Systems SR570 preamplifier to the 5 cm diameter Cu contacts at the center of the tile, on both sides, and its black terminal to the 6.7 mm Cu tape around the edges of the tile (Fig. 3). The preamplifier currents were translated into voltages using the SR570 feedback ammeter. Typical settings ranged from 5 to 100 μA/V. The feedback ammeter output was transferred to a computer using a Picoscope SB3206A oscilloscope.

3. Results

3.1. Hydraulic press experiments

First we report on an experiment with the plate glass tile, letting it sit for several hours at room temperature to allow any charges that might have accumulated to dissipate. As shown in Fig. 4a there was a small current in the 30 pA range, slowly decreasing with time. We loaded the glass tile from 0 to 50 MPa within 5 s and kept the load constant for over 2 h. During loading we observed no change in the current.

We repeated the experiment, after letting the glass tile sit overnight, this time measuring the voltage. As shown in Fig. 4b, just before loading, the surface potential was close to +859 mV. During loading it shifted by 1 mV to +860 mV.

Fig. 5a/b show the dramatically different current when subjecting a gabbro tile to the same procedure. Before applying the load the background current between center and edges was on the order of 10 pA. We loaded the tile within 1 s from 0 to 48 MPa and then kept it constant for about 100 min as shown in Fig. 5a. Upon loading an instant current was recorded, increasing rapidly almost 10,000-fold, to about 20 nA. At constant load this current decayed, rapidly at first to about 6–7 nA, then more slowly to about 5 nA.

Repeating the experiment but keeping the time at constant load 10 h and plotting the current on a logarithmic scale versus linear time *t*, produces a decay curve with three straight sections with

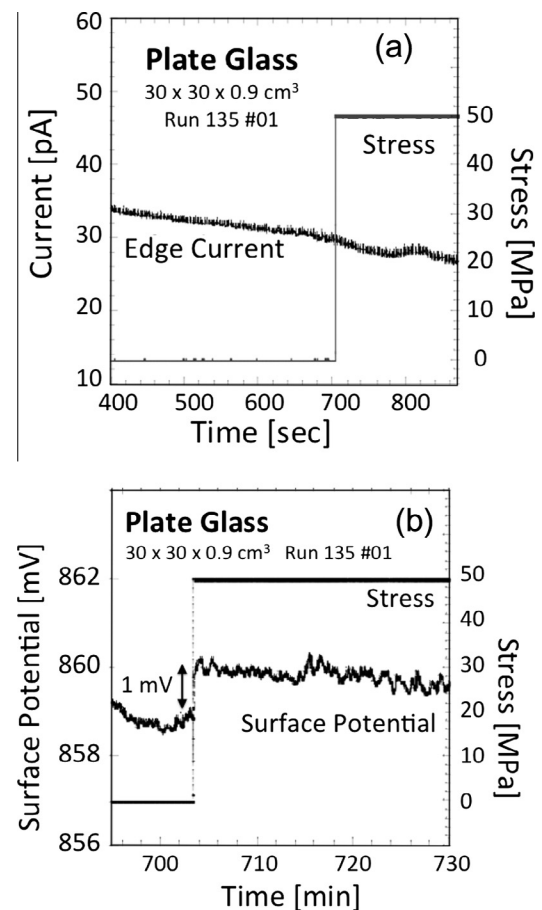


Fig. 4. (a and b) Current and surface potential changes of a plate glass tile, cut to the same dimensions as the rock tiles, during rapid loading from 0 to 50 Mpa.

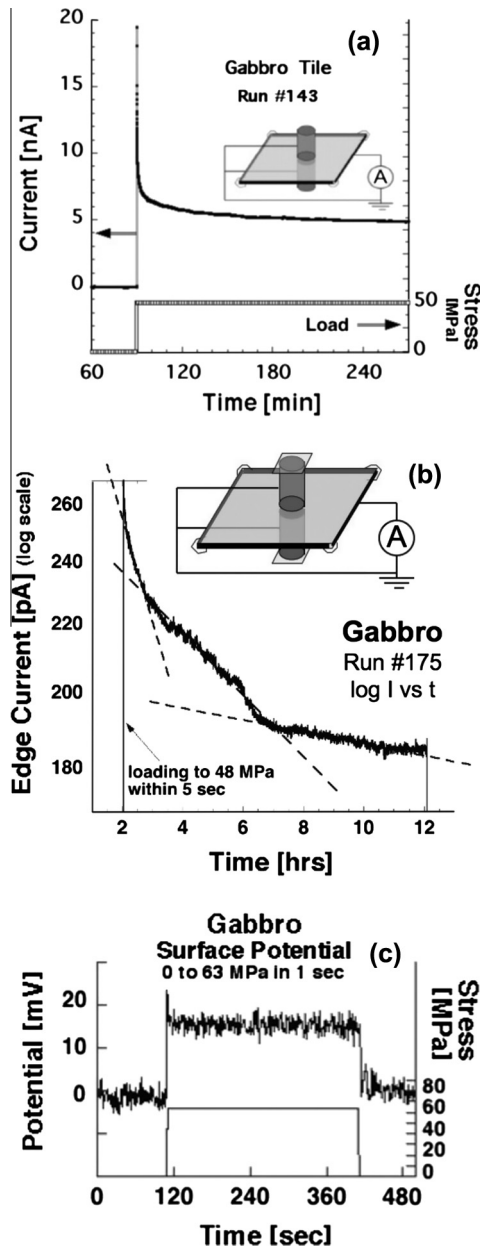


Fig. 5. (a) Load and current versus time during loading of a rock tile to 48 MPa within 1 s, followed by 3 h at constant load. (b) Surface potential versus time during loading of rock tile within 1 s to 58 MPa, holding the load constant from 50 s and releasing it at the same rate. (c) Decay of the positive outflow current over 10 h at a constant load of 48 MPa, plotted on a semilogarithmic scale. (b) Outflow current from a centrally stressed gabbro tile during a loading–unloading cycle to 48 MPa at a rate of 6 MPa/min. (b) Potential difference between the center of a gabbro tile and the rock surface during loading–unloading at 12.6 MPa/min.

different slopes as shown in Fig. 5c. These three sections suggest that the stress-activated current flowing out of the central rock volume is carried by charge carriers that anneal with different halftimes.

Following convention, the positive direction of a current is when electrons flow in the opposite direction (Berlin and Getz, 1988). This means that the positive direction of a current is the direction of the flow of holes. The centrally loaded gabbro tiles consistently produced positive currents from the stressed center to the edges, indicating outflow of holes.

Fig. 6a shows the current during a full cycle of loading and unloading a gabbro tile at a moderate constant rate, 6 MPa/min

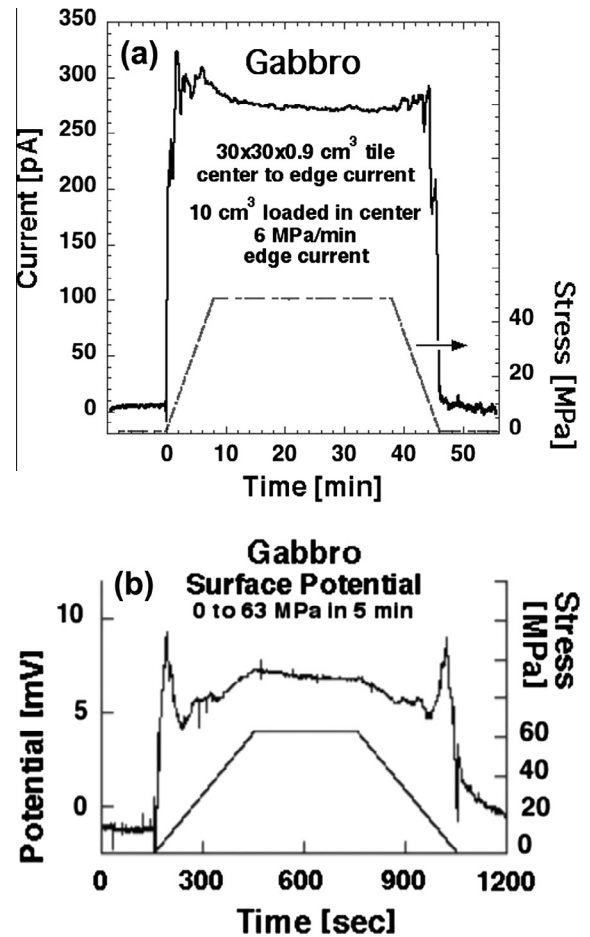


Fig. 6. (a) Outflow current from a centrally stressed gabbro tile during a loading–unloading cycle to 48 MPa at a rate of 6 MPa/min. (b) Potential difference between the center of a gabbro tile and the rock surface during loading–unloading at 12.6 MPa/min.

to 48 MPa, keeping the load constant for 30 min, followed by ramping down at 6 MPa/min. Fig. 6b shows the voltage during a similar cycle at different run parameters (rate, maximum load, dwell time). The results of both experiments are very similar with respect to the way the current and the voltage evolve.

The outflow current from the centrally stress rock volume is positive, and the potential difference between center and the surface of the tile is such that the surface becomes positive relative to the stressed center volume. Several additional features are noteworthy for the current:

- (i) The current before loading is negligibly small, on the order of a few hundred fA to a few pA, but often slightly different from tile to tile despite apparent homogeneity of the gabbro matrix.
- (ii) Upon loading the center of the tile, the current starts with a small excursion to negative values but then quickly turns positive, rising fast already at low load levels, reaching currents typically 100× stronger than the baseline current.
- (iii) The current passes through maxima and minima between 5 and 10 MPa while being loaded at the constant rate and saturate above 20 MPa.
- (iv) At constant load, 48 MPa, the current decreases slowly and steadily.
- (v) Upon unloading, similar current maxima and minima develop as during the loading phase with the main decrease in current only after the load has dropped to about the same

value as observed during the rapid increase of the current during loading.

- (vi) After the load has returned to zero, a small residual current flows often for hours before returning to the initial value in the few hundred fA to low pA range.

In the case of the voltage measurement depicted in Fig. 6b the gabbro tile, stressed at 12.6 MPa/min to 63 MPa and held for 5 min before unloading, develops a brief negative voltages at the very beginning and the very end, transitioning to a positive potential difference between the stressed center of the tile and the unstressed part. The voltage reaches its highest value around +10 mV soon after the beginning of loading, then drops to around +5 mV, increasing slowly as long as the stress increases. Once the stress level becomes constant, the potential difference decreases slightly, similar to the way the current decreases under constant load. The voltage reaches a high value as second time during unloading, when the load is already almost completely removed.

The similarity between voltage and current during the loading cycles indicates that the voltage, marking the self-generated potential difference between the stressed center to the unstressed edges, drives the current outflow.

The potential, here measured as voltage, is self-generated. Hence, the current is self-generated, flowing in response to a self-generated potential difference, not in response to an externally applied electric field. The fact that the highest currents and voltages are recorded at low stress levels, less than 5–10 MPa, calls into question explanations offered in the literature for pressure-stimulated currents and voltages, in particular the suggestion that they may be the result of improved grain–grain contacts (Glover, 1996; Nover, 2005) or of internal crack formation with carbon or graphite films forming spontaneously on the fracture surfaces (Nover et al., 2005).

If a gabbro tile is repeatedly loaded and unloaded, it produces nearly fully reproducible current profiles. An example is given in Fig. 7, where a gabbro tile was subjected over a period of 10½ h to 22 identical loading–unloading cycles from 0 to 48 MPa. Each cycle generated nearly identical outflow currents, consistently positive with maxima at low stress levels and at the end of each unloading. At constant 48 MPa stress the current reaches 240 pA, decreasing slightly, fewer than 5%, after 22 loading–unloading cycles.

It is remarkable that, once an elevated stress level has been achieved, there is a near-constant current flowing out of the stressed rock volume, decreasing only slowly with time. By contrast, when the load is removed, the outflow current drops precipitously when the load level has reach values below 5–10 < MPa.

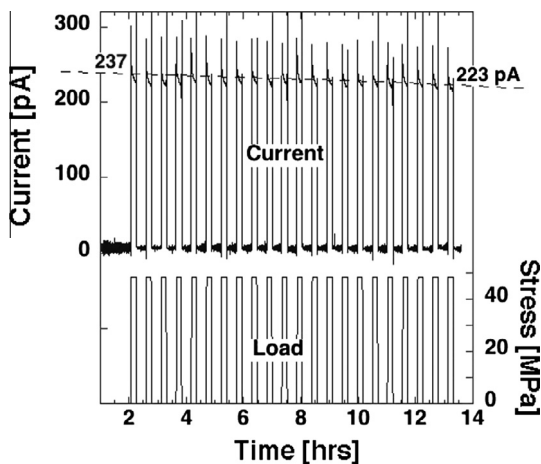


Fig. 7. Sequence of 22 loading–unloading cycles from 0 MPa to 48 MPa of a centrally loaded gabbro tile.

This observation is consistent with the concept that the rock represents a battery that is being “turned on” by applying a load and “turned off” by removing the load (Freund et al., 2006; Takeuchi et al., 2006). If the resistance in the outer circuit is low, the amount of current that can flow out of the stressed rock volume is controlled by the self-generated voltage and the internal resistance of the rock.

This is illustrated by Fig. 8, derived from a different measurement where a large block of gabbro, 30 × 60 × 10 cm³, was loaded along its center line to 28 MPa, using a pair of steel bars as pistons with a 30 × 5 cm² footprint. Applying the load produced an outflow current on the order of 170 nA. Keeping the load constant for 50 days, led to a steady decrease of the current to about one half its starting value after 49 days. The number of charge carriers flowing out of the 150 cm³ stressed volume over this time period is about 3 × 10¹⁸, equivalent to ~½ Coulomb.

To illustrate in more detail the onset of the self-generated currents flowing out of a 30 × 30 × 0.9 cm³ gabbro tile during loading we magnify in Fig. 9a–c the initial sections at three loading rates, 6 MPa/min, 60 MPa/min, and 600 MPa/min, marking arbitrarily, to aid the eye, the stress levels 5 MPa, 10 MPa, and 20 MPa.

One striking feature of Fig. 9a–c is that current maxima occur already at modest stress levels, ~5 MPa at loading rates 60 and 600 MPa/min. At the slower rate, 6 MPa/min, a first current maximum is reached at 5 MPa and a second, higher one at 10 MPa. Another striking feature is that the initial current maxima are higher than the currents flowing under steady load and they increase significantly in magnitude with the fast the rock tile is loaded. In summary, the characteristic features of the outflow of charges from a stressed subvolume are

- (i) Early onset of current outflow already at very low loads.
- (ii) Transient current maxima during the initial phase of the loading.
- (iii) Increase of the current maxima with increasing rate of loading.
- (iv) Current fluctuations after the initial maxima.
- (v) Slow decrease of the current under constant load.

The fact that the currents increase from 325 pA at 6 MPa/min to 390 pA at 60 MPa/min and to 820 pA at 600 MPa/min, suggests a stress–activation of charge carriers with different lifetimes during loading. Some charge carriers appear to be short-lived, deactivating within less than 1 s, others are long-lived with longer lifetimes. As the example in Fig. 8 has demonstrated, the lifetimes under constant load can be on the order of days to weeks, even months.

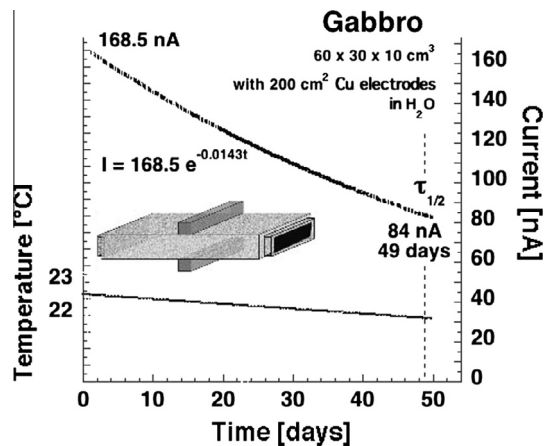


Fig. 8. Applying a constant load to a large block of gabbro and keeping it for 50 days leads to a continuous outflow current, which decays with a half-life on the order of 49 days.

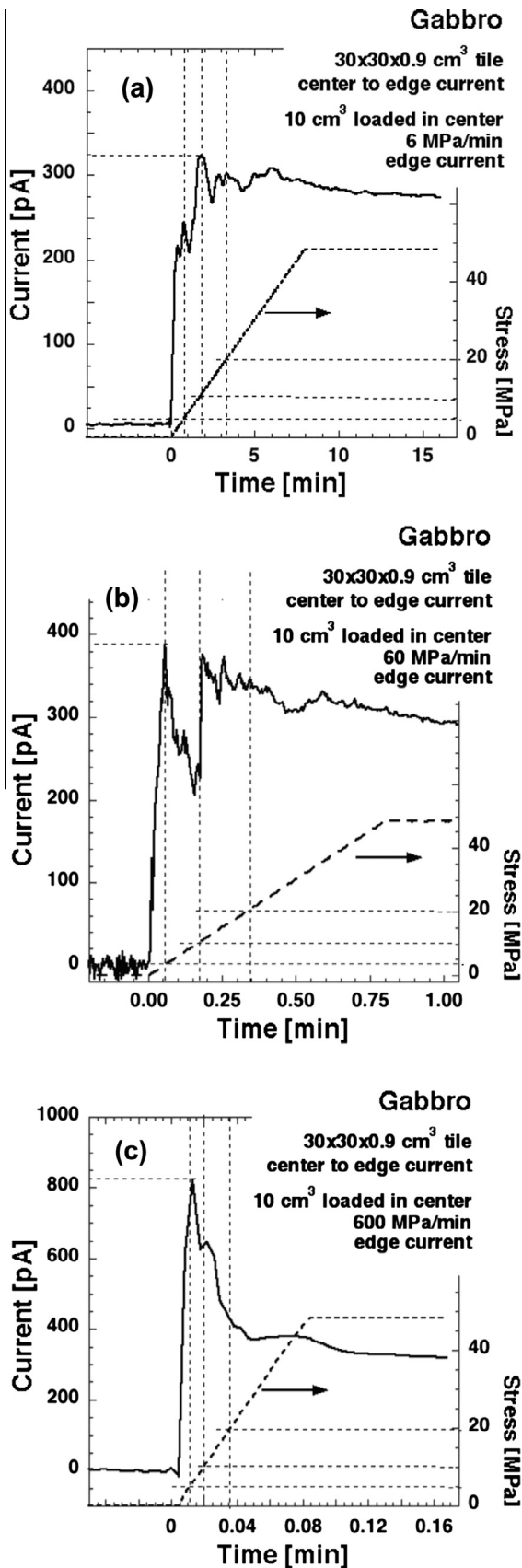


Fig. 9. A characteristic feature of the stress-activation of charge carriers in rocks are the rapid increase of the outflow current and the intense current fluctuations during the early phase when the gabbro tile is loaded at the constant rates: (a) at 6 MPa/min, (b) at 60 MPa/min, (c) at 600 MPa/min.

This characteristic behavior was further confirmed by setting up an experiment with a new gabbro tile and stressing it repeatedly, first slowly, then faster, covering 5 orders of magnitude of loading rates, from 0.24 kPa/s to 19 MPa/s. Upon reaching a time limit of 9 h or 58 MPa, the tile was unloaded and allowed to anneal for 2–4 h or longer before the next cycle.

Fig. 10 shows 11 cycles recorded at increasing constant loading rates up to a maximum load of 58 MPa, which corresponds to about $\frac{1}{4}$ the stress needed to cause the gabbro to fail. Even though the loading rates were constant, the outflow currents are not steady. They tend to fluctuate, in particular during the early loading stages. At slow rates the currents exhibit a cluster of rapidly changing values below 5 MPa. They eventually evolve into a sharp peak of high outflow current below 5 MPa at the fastest loading rates.

In Fig. 11 the same curves are plotted on the same scale. The values confirm that the outflow currents increase sharply at the beginning of loading and that, at the higher stress rates, the initial maximum increases sharply with the increasing rate. Note that Fig. 10 shows that the overall saturation currents increase the faster the loading rate. They do not level out but instead continue to increase as long as the loading continues at the constant rate.

Fig. 12 plots the initial current maxima for 7 of the 11 runs as outflow current per km³ versus log (time). The current maxima increase rapidly with increasing rate, approaching 10^6 A km³ at the fastest rate shown, about 20 MPa/s. The increase is faster than exponential. Fig. 13 plots the peak current versus the ramp. The data suggest that, if the stress rate can be further increased, even larger outflow currents might be expected.

3.2. Drop tower experiments

During the hydraulic press experiments the rate of stress increase was always linear. During the impact experiments the rate was approximately parabolic. Many tiles broke under impact or cracked. By reducing the height from which the 90.7 kg mass was dropped to between 15 and 25 cm and using felt pads to cushion the impact, spreading the time of compaction to about 1 ms, we achieved conditions that did not lead to fracture. Once these conditions were established and a tile survived, we impacted the same tile several times with only a few minutes between drops.

Consistent with the results of the hydraulic press experiments, the outflow currents resulting from dropping the 90.7 kg mass on the 5 cm diameter steel piston in the center of the tile were always positive. This confirms that positive holes are the charge carriers flowing from the stressed subvolume at the center of the tile to the outer unstressed region. Electrons are mobile only within the stressed rock volume (Freund, 2007, 2013). After each positive outflow pulse, a weak negative current was observed lasting for about 25–30 ms. This suggests that, after each outflow pulse, some of the positive charge carriers are being pulled back toward the center of the tile. The first drop had a minimal 'reflux' as shown in Fig. 14a. Subsequent drops on the same tile, Fig. 14b–e, produced – in the integral – slightly stronger negative currents, but the net current always remained positive. This is illustrated in Fig. 15.

Linearly extrapolating the maximum positive outflow current pulse from ~ 20 cm³ to the current that would flow out of 1 km³ of rock gives $1\text{--}2 \times 10^9$ A. This is consistent with the empirically determined increase in outflow current as a function of the rate of compression as depicted in Figs. 10 and 12.

In all other cases shown in Figs. 14b–e, where we re-impacted the tiles within a few minutes, the amount of positive charge flowing out of the stressed subvolume was roughly the same as after the first impact in Fig. 14a, but the amount of negative charges flowing back was slightly larger. The difference in the response

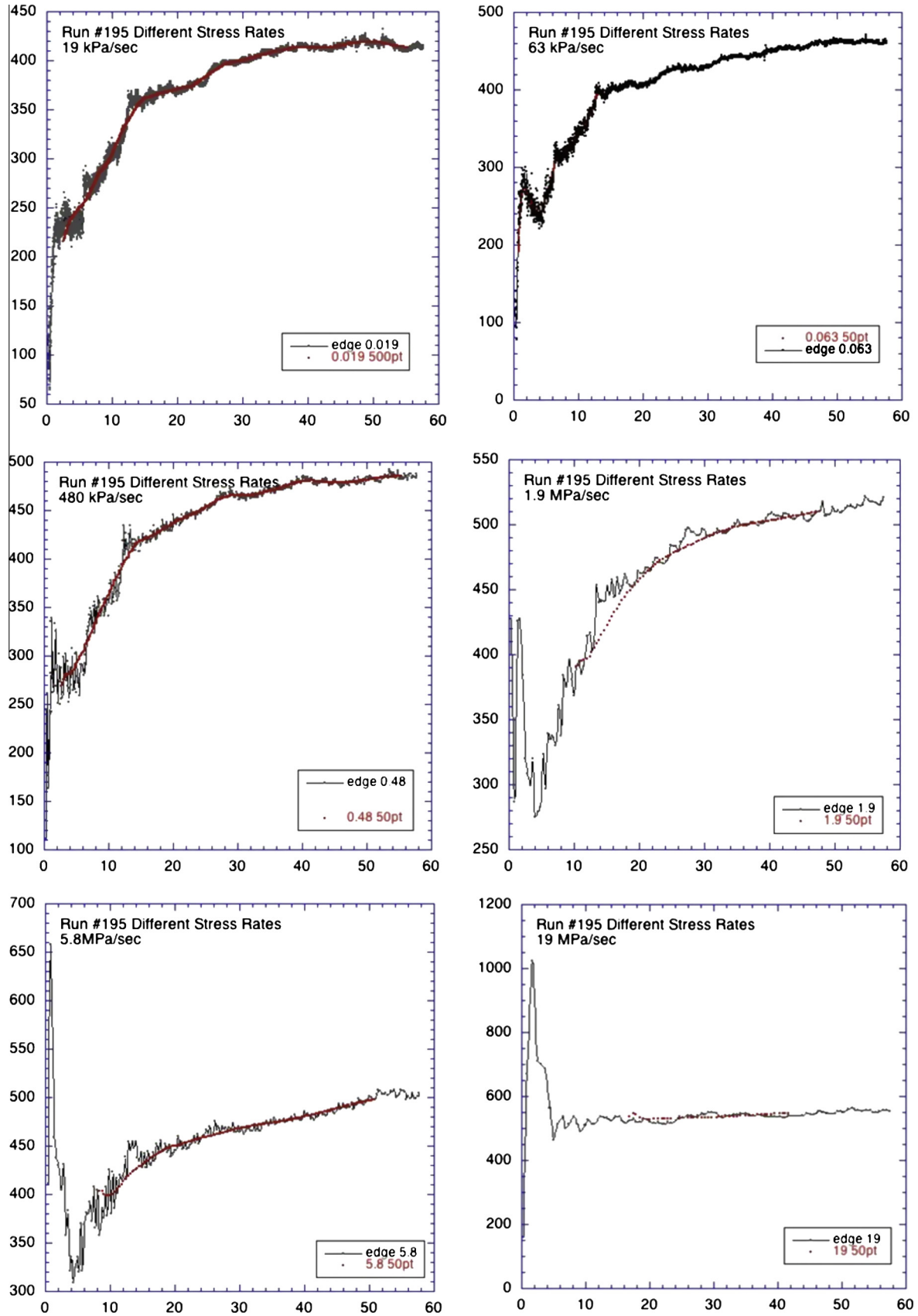


Fig. 10. Outflow currents from a centrally loaded gabbro tile, 10 cm³ stressed rock volume, at different stress rates covering nearly 5 orders of magnitude, up to a maximum load of 58 MPa.

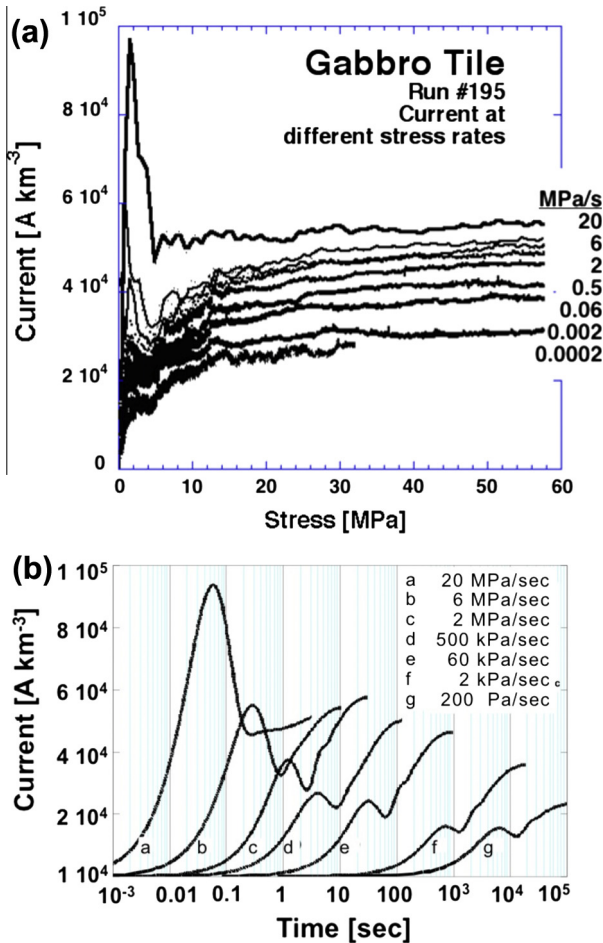


Fig. 11. (a) Outflow currents from a centrally loaded tile at different loading rates spanning 5 orders of magnitude. (b) Initial current maxima plotted as current on a linear scale versus time on a logarithmic scale for different loading rates.

of a fresh impact versus repeated impacts was probably due to less charge carrier recombinations during the short time between drops, only a few minutes. The relatively long “tail” with different slopes in Fig. 15 suggests that multiple species of charge carriers were recombining on different time scales.

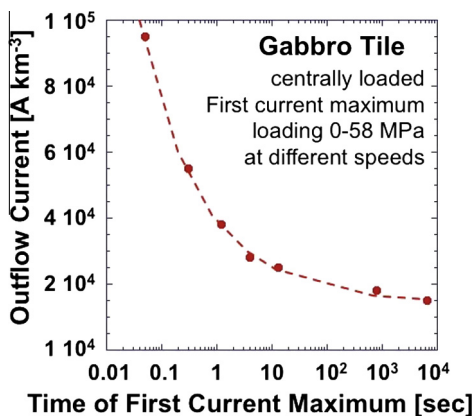


Fig. 12. Plot of the peak current (in A km^{-3}) versus the speed with which the load is applied. Curve fitting suggest that, if the ramp can be made even shorter, outflow currents from the centrally loaded gabbro tile equivalent to outflow currents on the order of 10^6 A km^{-3} might be achievable.

4. Discussion

Stress gradients are created by the tectonic forces that wax and wane in the Earth’s crust. During the days, weeks, even months prior to major earthquakes the stresses may evolve, eventually reaching a point of catastrophic rupture. Recognizing that electric charge carriers are activated in the stressed rock volume and that they can flow out, spreading fast and far, may help us understand pre-earthquake signals.

Fig. 4a/b show an example of a material, Ca–Na–aluminosilicate glass as used in common window panes, which does not provide evidence for any stress-activated charge carriers that could flow out of the stressed central part of a glass plate, producing a measurable current. The 1 mV potential difference that shows up in the moment the stress was applied in this particular experiment was not sufficiently reproducible to warrant further attention. By contrast, whenever we loaded a gabbro tile, reproducible patterns of stress-stimulated outflow current and stress-stimulated surface potentials were observed. The surface potentials and outflow currents were always positive, supporting the conclusion reached in previous publications that the responsible mobile charge carriers are positive.

Positive holes have previously been reported to be able to flow out of a rock volume, in which they were activated by stress, spreading along the stress gradient into and through adjacent unstressed rock, traveling fast and far (Freund, 2002; Freund et al., 2006).

Most published reports of pressure-stimulated currents are based on experiments conducted with rock samples subjected to quasi-uniform loading (Fig. 1b) (Aydin et al., 2009; Johnston, 1997; Kyriazis et al., 2009; Triantis et al., 2006; Tullis, 2002; Vallianatos and Triantis, 2008). By contrast, in all cases described here we purposefully created stress gradients between the stressed center and the unstressed edges. We noted that, as soon as we began loading the center of the rock tiles, after a brief negative current, mobile positive charge carriers appear that are capable of flowing out of the stress subvolume into and through the unstressed rock. These charge carriers cause (i) a potential difference between the stressed central rock volume and the unstressed edges, i.e. a pressure-stimulated voltage, and (ii) a current to flow out of the stressed subvolume, i.e. a pressure-stimulated current. Minor short negative signals were recorded at the beginning and the end of each individual loading–unloading cycles (Fig. 6a/b) and at the beginning and the end of many loading–unloading cycles (Fig. 7), but the sign of the dominant signals is persistently positive, indicating that the overwhelming majority of stress-activated charge carriers in the gabbro tiles are positive. We have focused here on these positive charge carriers.

In semiconductors negative and positive electronic charge carriers have been known for decades. The negative charges are electrons. The positive charges are sites where an electron is missing, hence defect electrons, also known as “holes” (del Alamo, 2011; Sze, 1981).

Subjecting the gabbro to uniaxial stresses leads to the activation of hole charge carriers, which must have existed in the rock prior to the application of stress, albeit in an electrically inactive, dormant state. This is fundamentally different from normal semiconductors where electrons and holes, introduced by doping the materials with aliovalent impurities, are always active. They are introduced respectively by N substituting for Si in a silicon crystal to introduce mobile electrons for n-type silicon or by B substituting for Si to introduce holes to make p-type silicon (Sze, 1981). In a rock like the gabbro under study here the precursors to the stress-activated holes, must have been introduced by a fundamentally different process.

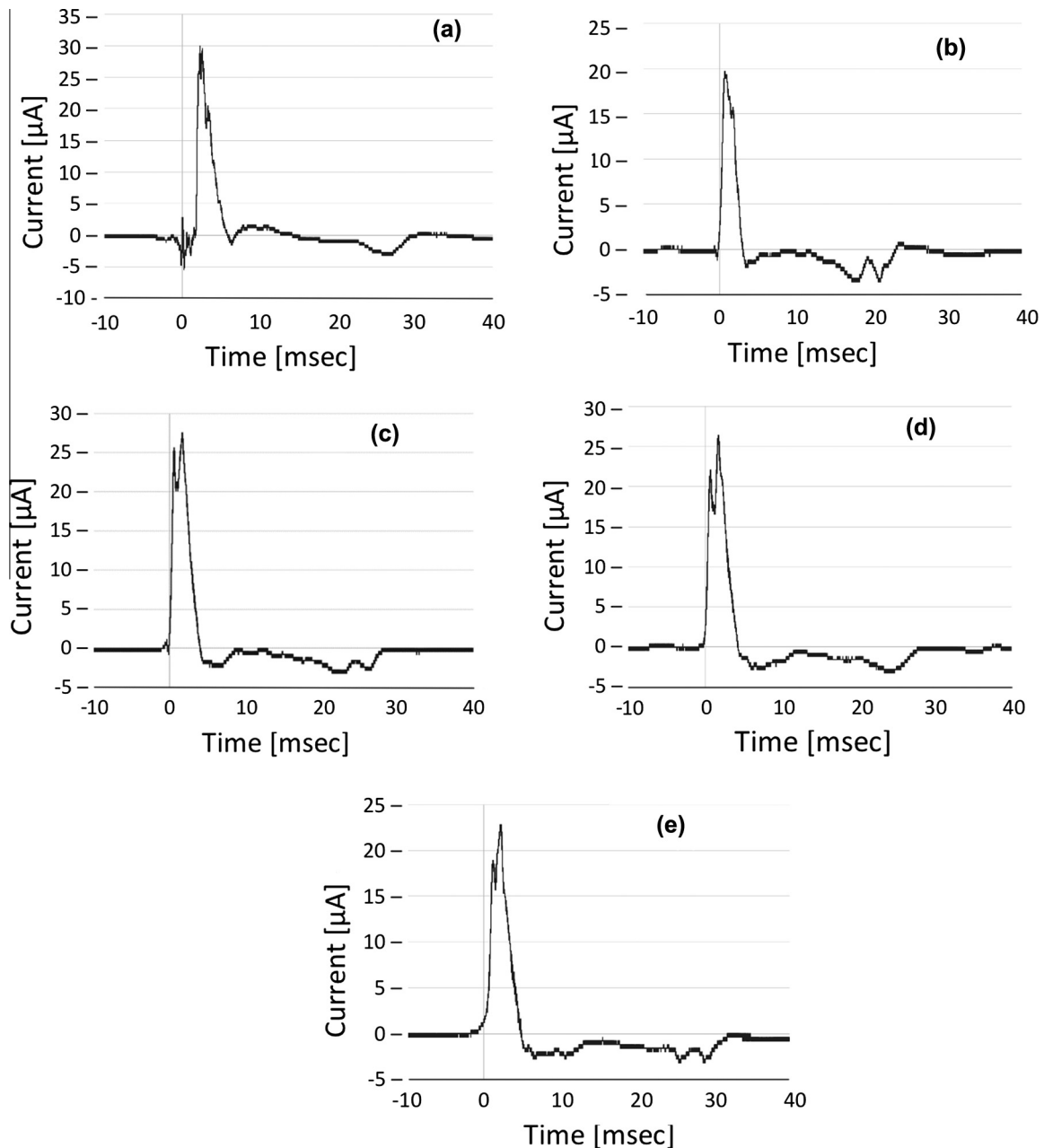


Fig. 13. (a–e) Currents resulting from centrally loading a tile by dropping a 90.7 kg weight on a piston in the center of the tile. The current pulse was always positive. A weak negative current was observed after the impact over a longer period of time. The first drop on a 'fresh' tile, a, had a minimal 'reflux' of negative current. Subsequent drops, b–e, produced more negative current, but the net currents always remained positive.

Another noteworthy observation during our experiments with the gabbro tiles is that the activation of the holes, hence, the currents flowing out of a given rock volume are not related in a simple way to the stresses applied. Low stress levels, <10 MPa, are enough to create surprisingly high outflow currents, indicating that a large number of holes are being activated, but holes also continue to be activated as upon further loading. When the stresses are constant, the currents decrease slowly, but intermittent additional loading causes transient increases in the outflow currents (Takeuchi et al., 2006). When the stresses are removed, the outflow currents eventually decrease very rapidly, indicating that most of the holes return to an inactive, dormant state. Some take longer. After the samples were annealed for various lengths of time, deactivating the holes, they become reactivated when stresses are reapplied. This procedure can be repeated many times.

Yet another remarkable feature is that, once activated, the holes have the ability to flow out of the stressed subvolume in the center to the unstressed edges of the tiles. The faster the stresses are applied, the larger the outflow currents. When a constant load is maintained, i.e. when a steady stress gradient is maintained between center and the edges of the tile, the hole outflow continues, lasting for hours, even days, weeks and months, indicating very long lifetimes, but will eventually stop when all charge carriers have recombined.

To address these points we need to understand

- (i) Where do these charge carriers come from?
- (ii) What is the nature of the stress-activated holes?
- (iii) Why are they activated already at very low stress level?
- (iv) Why are they able to flow through unstressed rock?
- (v) How long do they live before recombining?

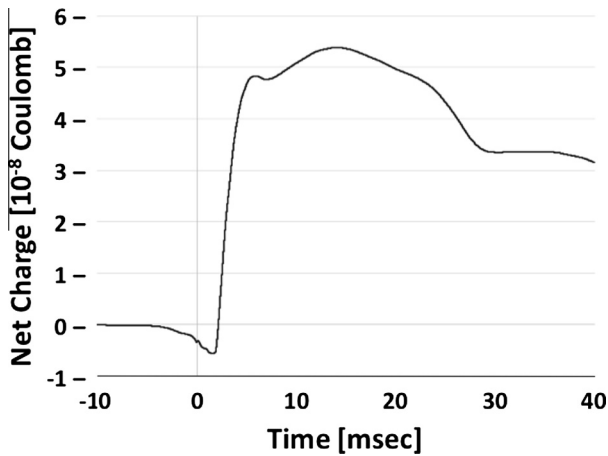


Fig. 14. Net flux of charges during the first drop, resulting from integrating the curve in Fig. 13a. Most of the positive charge, which flowed out during the initial pulse, persists at the end.

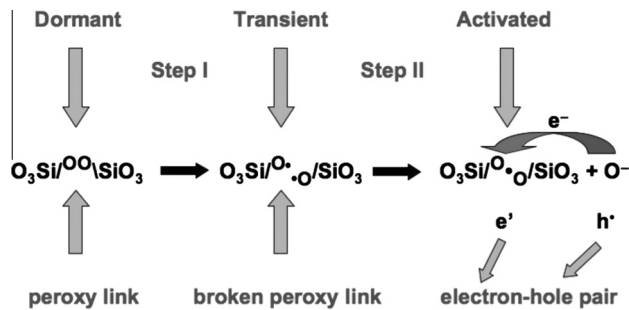


Fig. 15. Schematic representation of the break-up of a peroxy bond in a silicate matrix. Step I marks how the break-up of the dormant peroxy defect; Step II marks the electron transfer from an O^{2-} into the decoupled peroxy bond and the generation of an electron-hole pair.

4.1. Peroxy defects and positive holes

Among the many different types of point defects in rock-forming minerals, peroxy defects have not received much attention, even no attention at all, in the geoscience community.

Peroxy defects consist of pairs of covalently bonded oxygen anions in the valence state 1– instead of the usual 2–. First identified in MgO single crystals (Freund and Wengeler, 1982) and characterized through a wide range of physical techniques (Freund et al., 1993), the presence of peroxy defects was also indicated in silica (Freund and Masuda, 1991) and silicates (Freund, 1985). A typical peroxy defect in a silicate mineral would be $O_3Si-O-O-SiO_3$ replacing the common $O_3Si-O-SiO_3$. Because the O^-O^- distance in the peroxy bond is very short, less than 0.15 nm as compared to typical $O^{2-}-O^{2-}$ distances on the order of 0.28–0.3 nm, the volume occupied by a two O^- in the peroxy bond is comparable to the volume occupied by a single O^{2-} or a single OH^- . This implies that high pressures should favor the right hand side of Eq. (1) given at the very beginning of the Introduction and tend to stabilize peroxy.

As long as peroxy bonds are intact and the two O^- tightly coupled, peroxy defects are electrically inactive. Their presence has little or no effect on the physical properties, specifically on the electrical properties, of the minerals and rocks in which they occur. The small partial molar volume and lack of electrical activity explains why peroxy defects are so inconspicuous and have been consistently overlooked in the past. However, when peroxy bonds break and become activated, the situation changes.

Fig. 16 illustrates the way a peroxy defect breaks up in a silicate matrix. The activation of the peroxy bond leads first to a transient state, probably short-lived, where the O^-O^- bond is decoupled but not yet dissociated (Freund et al., 1993). The two O^- states are each represented by a dot \cdot , meaning by a hole. Next, a neighboring O^{2-} transfers an electron into the decoupled, half-broken peroxy bond. This process consumes one of the holes. As the electron becomes trapped, the O^{2-} , which acted as the electron donor, turns into an O^- , e.g. into a hole h^+ .

Fig. 16 thus depicts the formation of an electron–hole pair, where the electron e^- is trapped in the broken O^-O^- bond, while the electronic state associated with O^- in a matrix of O^{2-} represents a defect electron or hole, symbolized by h^+ (Freund, 2011, 2013). Holes associated with monovalent oxygen are different from holes associated with aliovalent substitutional impurities in classical semiconductors, for example boron in silicon. Therefore the hole states associated with O^- have been given the name “positive holes”² (Griscom, 1990).

Fig. 16 shows schematically the upper edge of the valence band, which consists primarily of energy levels that derive from O 2sp-type orbitals. Using the designation from Molecular Orbital Theory (Marfunin, 1979; Tossell, 1983) for the electronic structure of O_2^{2-} , the highest occupied levels in the peroxy defect are non-bonding $1\pi_g^{nb}$ levels, while the antibonding $3\sigma_u^*$ level is empty. Thus, the peroxy defect causes a dip in the energy surface at the uppermost edge of the valence band, which is indicated in Fig. 17 by the bold line.

Fig. 18a shows schematically the corresponding energy diagram with the valence and conduction bands separated by a wide band gap E_{gap} . In silicate minerals E_{gap} is typically above 5–7 eV – too wide for electrons in the valence band to be thermally activated to the conduction band at the low to moderate temperatures encountered in most of the Earth’s crust. Hence, silicate minerals and the rocks, which they form, will not exhibit conductivity by electrons promoted to the conduction band, leaving holes in the valence band. Therefore, if rocks exhibit stress-activated electronic conductivity, the underlying process must be fundamentally different. This is underlined by the observation reported here that the stress-activated conductivity of the gabbro tiles studied here is not carried by electrons but by positive holes.

To explain what seems to be happening at the edge of the valence band of peroxy-laden minerals we need to take a look at the energy levels involved. As indicated in Fig. 17 the highest occupied energy levels in the two oxygens making a peroxy bond are of π_g symmetry. They derive from the $O2p_x$ and $O2p_y$ orbitals, which form a torus around the O^-O^- bond (Marfunin, 1979; Tossell, 1983), but are essentially non-bonding (superscript “nb”). As long as peroxy defects are intact, their electrons in the $1\pi_g^{nb}$ level are spin-paired and, hence, strictly localized as indicated in Figs. 17 and 18a. Break-up of the peroxy bond can be achieved by bending it along the O^-O^- axis, thereby lifting the 4-fold degeneracy of the $1\pi_g^{nb}$ levels and causing two of the non-bonding π^{nb} electrons to transition into the antibonding σ_u^* level, which is being pulled down. This splits the $1\pi_g^{nb}$ energy level as depicted in Fig. 18b, trapping the electron transferred from a neighboring O^{2-} on a new energy level below the edge of the valence band. The remaining hole state forms the delocalized positive hole by mixing the π_g^{nb} level with the antibonding $3\sigma_u^*$ level of the surrounding O^{2-} (Freund et al., 1993).

Fig. 18a/b translate the positive hole activation into an energy diagram, where the newly created energy level $-\delta E$ below the valence band edge, which is occupied by the trapped electron,

² In semiconductor parlance “holes” are positive charge carriers. The name “positive hole” is redundant.

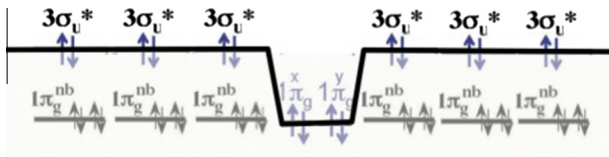


Fig. 16. The energy levels forming the upper edge of the valence band are of O 2sp symmetry. In the case of O²⁻ the highest occupied level is antibonding 3σ_u^{*}, while in the case of O₂²⁻ it is the non-bonding 1p_g^{nb} level.

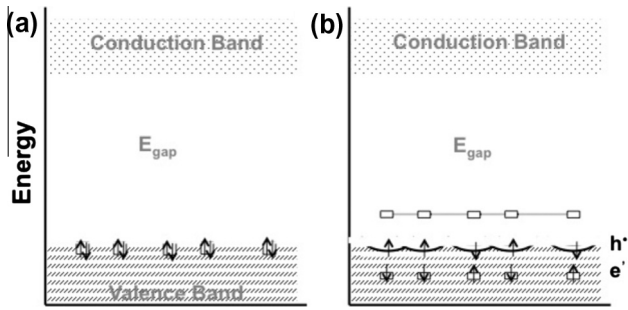


Fig. 17. (a) Schematic of the valence and conduction bands with peroxy defects indicated by dips in the upper edge of the valence band. (b) The break-up of the peroxy defects creates new energy levels, $-\delta E$ below the edge of the valence band, which are occupied, and $+\delta E$ above the edge of the valence band, which are empty.

has a mirror level $+\delta E$ above the valence band edge that is intrinsically empty as indicated by the open rectangles in Fig. 18b. The delocalization of the positive hole is indicated by the cusps at the very edge of the valence band. The $+\delta E$ level above the edge of the valence band is available to be thermally populated by the electrons trapped in the $-\delta E$ level below the edge of the valence band. The number Π of electrons on the $+\delta E$ level is given by $\Pi = \exp[-(2\delta E/kT)]$, where k is the Boltzmann constant and T the absolute temperature.

The hole states discussed here are distinct from another peroxy-related species, namely the peroxy radical, O₂⁻, which can be viewed as a peroxy entity from which an electron has been removed without breaking the close coupling between the two O⁻. Though the removal of an electron from the peroxy entity is formally equivalent to the addition of a hole, the energy levels occupied in the peroxy radical are different from those that mark the reversible break-up of the peroxy bond as a function of temperature as discussed in Part I (Freund and Freund, 2015). The peroxy radical is a species generated by ionizing radiation at cryogenic temperatures, typically 77 K (Griscom, 2001).

In summarizing this section, we can state with some degree of confidence that the energy diagram depicted in Fig. 18b provides the basis for understanding why the boundary between the

stressed and unstressed subvolumes acts as a barrier for electrons, while positive holes are able to pass through this boundary and propagate through the adjacent unstressed rocks.

Since the valence bands of mineral grains in rocks are electronically connected via their O 2sp-type energy levels at the upper edge of the valence band, once positive hole charge carriers are formed, they will be able to propagate through grains and across grain boundaries, subject to only minor scattering, flowing outward well beyond the boundaries of the stressed subvolume.

The propagation of positive holes is believed to occur by way of a phonon-assisted electron hopping mechanism (Shluger et al., 1992) (Fig. 18). In order for a positive hole to travel from left to right as indicated by the solid red triangles, a succession of electrons has to hop from right to left.

The highest probability for an electron to execute a hop is when the distances between neighboring oxygen atoms are shortest. The highest velocity the h⁺ can achieve is thus given by the phonon frequency ν , which modulates the inter-atomic distances, times the hopping distance. Taking ν as 10¹² Hz and the hopping distance d between O²⁻ sites as 0.28 nm, the highest speed for positive holes to propagate into any direction of x - y - z coordinates via a phonon-assisted electron hopping mechanism, $\nu d/3$, is on the order of 93 m/s (Shluger et al., 1992), consistent with the values determined here (see below) and not too far outside the range of the estimated value, 200 ± 100 m/s, derived from earlier impact experiments (Freund, 2002).

In our free-fall impact experiments the peak of the positive outflow current is well resolved, allowing us to estimate the travel time of positive holes to the edges of the tiles. Since we used square tiles, the charge carriers will not flow with equal probability along all possible directions but preferentially along the paths of least resistance.

With a Cu contact along the edge of the tiles, the path of least resistance is the shortest distance from a point in the 5 cm diameter central source area to the closest point on the edge.

Integrating over the circular source area at the center and normalizing over all possible paths, the average path of least resistance is $\frac{1}{2} - \frac{4r\sqrt{2}}{3\pi}$ with r the radius of the central contact, 25 mm, and L the edge length of the tile, 30 cm. The mean path length of least resistance is thus ~ 13.7 cm.

On impacting the piston in the center of a tile the median time between impact and the maximum of the positive peak was found to be 1.45 ms, corresponding to an h⁺ velocity of 95 ± 25 m/s, which favorably compares to the values of 200 ± 100 m/s derived from early impact experiments on rock cylinders (Freund, 2002).

Alternative mechanisms such as streaming potentials (Revil et al., 2003) have been proposed to explain electrical currents in stressed rocks. Regarding streaming potentials, the rocks in these experiments were all air dry, although it is possible that some amount of water in pores or intergranular space was retained. However, propagation velocities of ~ 100 m/s can only be

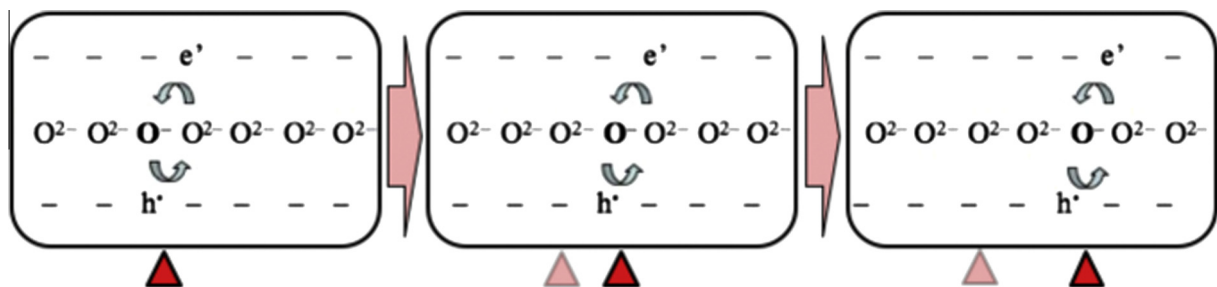


Fig. 18. Schematic representation of a positive hole, h⁺, moving from left to right through a succession of electron hops from right to left.

accounted for by charge carriers that are electronic in nature. Such velocities are far too rapid for streaming potentials, which require the transport of cations and/or anions through a porous medium. Moreover, Fig. 8 shows that the positive currents slowly decay over a period of 50 days. Streaming potentials could not continuously transport ions in fluid through the tiles for such an extended duration. Also, there is no continuous stress gradient from the center to the boundary of the tile that would drive a streaming potential. For these reasons, the experimental results indicate that positive holes rather than streaming potentials are responsible for the currents observed in these experiments.

4.2. Applying laboratory observations to the field

When tectonic forces act on rocks deep in the Earth crust subjecting them to increasing levels of stress, e^- and h^+ charge carriers will be generated through the stress-activation of peroxy defects. As demonstrated in this paper, the h^+ charge carriers have the ability to flow out of the rocks subjected to stress. They spread into and through unstressed rocks. By contrast, the co-activated e^- charge carriers, i.e. electrons, are mobile only inside the stressed rock volume.

The outflow of h^+ charge carriers from a stressed subvolume is driven by the h^+ concentration gradient along the stress gradient. The mechanism by which the h^+ propagate does not depend on the presence of intergranular carbon films nor on the presence of intergranular connected fluids. However, to the extent that intergranular carbon films are present, they may play a role in closing the circuit by allowing electrons to also flow out. Their outflow via carbon films would be equivalent to the outflow of the electrons in our laboratory experiments depicted in Figs. 1c and 2b where we show a Cu contact attached to the stressed rock subvolume and a Cu wire that runs to the other Cu contact at the unstressed end of the rock sample. Likewise, if the rocks contain networks of interconnected intergranular aqueous films, circuit closure could be achieved by hydronium ions, H_3O^+ , or cations flowing in the intergranular space.

It is also possible for holes to escape the stressed rock volume without any sort of circuit closure. In a material containing free charge carriers, electric fields are screened on length scales longer than the Debye length, which is typically microscopic in semiconductors. This means that if positive holes travel far enough from their negatively-charged source volume, they no longer experience a restoring Coulomb force and become free to propagate outward along the stress gradient. This typically involves a double-layer of positive and negatively charged regions whose electric field is screened outside its immediate vicinity. The build-up of a persistent surface charge (Freund, 2002) indicates that charge is being screened in this way.

The electrical conductivity of igneous rocks increases exponentially with temperature over the 300–650 °C window, characterized by an activation energy around 1 eV (Parkhomenko and Bondarenko, 1986), suggestive of h^+ as dominant charge carriers as argued in Part I. Thus, in the field, along the geotherm, the outflow of stress-activated h^+ can be expected to increase with depth. This should allow for higher h^+ current densities flowing out of stressed rock volumes deeper in the crust.

Any flow of h^+ through the rocks constitutes an electric current. If circuit closure can be achieved as discussed here, the h^+ outflow along stress gradients may form a current that can persist for a period of time, either in a quasi-dc mode or fluctuating. A dc outflow current that waxes and wanes slowly, over a long time period, would lead to a drift of the regional magnetic field strength measurable at the Earth surface.

For instance, before the magnitude 7.6 Chi-Chi earthquake of September 21, 1999, an 8-station network of total magnetic field

sensors in operation in Taiwan since 1989 (Chen et al., 2004) recorded a slow, but steady drift of the magnetic field over the Northwestern part of the island, starting in 1997. It resulted in an “anomaly” relative to the International Geomagnetic Reference Field Finlay et al. (2010), the maximum of which reached about 250 nT and was concentrated where the Chelungpu Fault would rupture during the Chi-Chi event. Seven weeks before the Chi-Chi earthquake the magnetometer station closest to the Chelungpu Fault started to record strong magnetic field fluctuations with amplitudes up to 250 nT, suggesting that the current below had transitioned from a quasi-dc mode to an ac mode, leading to persistent ultralow frequency (ULF) emissions in the range of millihertz (Freund and Pilorz, 2012; Yen et al., 2004). Increased ULF activity has been recorded at the Earth surface before other major earthquakes as well (Bleier et al., 2009; Chavez and Millan-Almaraz, 2010; Hall et al., 2004; Sharma et al., 2011; Smirnova et al., 2013).

One of the findings of our study presented here is that the amount of charge flowing out of a given volume of gabbro during a period of increasing stress at ambient temperature is relatively constant, about 10^6 Coulomb km^{-3} during loading from 0 MPa to about 60 MPa, irrespective of how fast the stresses are applied. If the stresses are applied within 1 s, the current outflow will be on the order of 10^6 A km^{-3} . In the free-fall experiments, central loading 18 cm^3 of the tile within about 1–1.5 ms led to a current outflow on the order of 20–30 μA . Linearly extrapolating this values to a rock volume of 1 km^3 would give $\sim 10^9$ A.

5. Conclusions

The experimental work presented here shows that loading the center of gabbro tiles leads to electric currents that flow out of the stressed subvolume to the unstressed edges. A potential difference develops between the center and the edges, which drives the outflow currents already at low stress levels, >1 MPa. There are brief transient negative voltages and currents, but the main outflow currents are consistently positive. They grow with the applied load, rapidly at first, going through maxima and minima, then increase steadily as the load is increased at constant rates to stress levels between 48 MPa to 64 MPa, about $\frac{1}{4}$ of the fracture strength of the gabbro under study. If the load is kept constant, the currents continue to flow for hours, days, weeks and even months, slowly decreasing with time. Increasing the loading rates over 5 orders of magnitude, from 0.2 kPa/s to 20 MPa/s, causes the peak outflow currents to also increase. The integrated charge flowing out was found to be on the order of 10^6 Coulomb km^{-3} , relatively independent of the rate at which the stresses are applied.

The rate of loading was further increased by another 3 orders of magnitude using drop tower experiments, stressing the rock tiles parabolically within 0.5–2 ms without fracture. Very large positive outflow currents are recorded, lasting 4–6 ms and reaching up to 30 μA flowing out of 20 cm^3 of rock. Linearly extrapolating this to 1 km^3 of rock gives a value of $1-2 \times 10^9$ A km^{-3} .

It appears that no other research groups ever conducted experiments, where only a subvolume of rock is subjected to stress. The most likely reason is that the flow of stress-activated electric currents from a stressed rock volume into and through unstressed rocks was deemed impossible. Hence, no attempts were made to measure stress-stimulated currents and voltages with the appropriate sample geometry (Fig. 1c–d). Setting up such experiments became sensible only after a basic understanding had been achieved about the nature of peroxy defects and about their ability to generate positive hole charge carriers, which can flow out from stressed rocks into and through unstressed rocks. Though peroxy defects are ubiquitous, their presence and influence – possibly

controlling influence – on the electrical properties of rocks have not yet attracted the level of attention in the geoscience community that they deserve.

Acknowledgments

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